Application/Control No. Applicant(s)/Patent Under Reexamination 09/834,617 TAKAHASHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 EDMUND H. LEE 1732 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,149,479 09-1992 Nakajima, Hideo 264/163 Vavalidis, Kyriakos US-5,772,240 06-1998 280/728.3 В 08-2000 Totani et al. 280/728.3 С US-6,109,645 US-5,989,479 11-1999 Yamasaki et al. 264/510 D Ε U\$-F US-US-G US-Н US-1 US-Κ US-USı US-M FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Country Name MM-YYYY Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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